

# MBN500H65E2

Silicon N-channel IGBT 6500V E2 version

## FEATURES

- \* Low driving power due to low input capacitance MOS gate.
- \* Low noise due to ultra soft fast recovery diode.
- \* High reliability, high durability module.
- \* High thermal fatigue durability.  
( $\Delta T_c=70^\circ\text{C}$ ,  $N>30,000$ cycles)
- \* Isolated head sink (terminal to base).

## ABSOLUTE MAXIMUM RATINGS ( $T_c=25^\circ\text{C}$ )

Item	Symbol	Unit	MBN500H65E2
Collector Emitter Voltage	$V_{CES}$	V	$T_j=125^\circ\text{C}$ 6,500
			$T_j=25^\circ\text{C}$ 6,500
			$T_j=-40^\circ\text{C}$ 6,000
Gate Emitter Voltage	$V_{GES}$	V	$\pm 20$
Collector Current	DC	$I_C$	500 ( $T_c=80^\circ\text{C}$ )
	1ms	$I_{Cp}$	1,000
Forward Current	DC	$I_F$	500
	1ms	$I_{FM}$	1,000
Junction Temperature	$T_j$	$^\circ\text{C}$	-40 ~ +125
Storage Temperature	$T_{stg}$	$^\circ\text{C}$	-50 ~ +125
Isolation Voltage	$V_{ISO}$	$V_{RMS}$	10,200 (AC 1 minute)
Screw Torque	Terminals (M4/M8)	-	2/10 (1)
	Mounting (M6)	-	6 (2)

Notes: (1) Recommended Value  $1.8\pm 0.2/9\pm 1\text{N}\cdot\text{m}$

(2) Recommended Value  $5.5\pm 0.5\text{N}\cdot\text{m}$

## ELECTRICAL CHARACTERISTICS

Item	Symbol	Unit	Min.	Typ.	Max.	Test Conditions
Collector Emitter Cut-Off Current	$I_{CES}$	mA	-	-	17	$V_{CE}=6,500\text{V}$ , $V_{GE}=0\text{V}$ , $T_j=25^\circ\text{C}$
			-	17	67	$V_{CE}=6,500\text{V}$ , $V_{GE}=0\text{V}$ , $T_j=125^\circ\text{C}$
Gate Emitter Leakage Current	$I_{GES}$	nA	-500	-	+500	$V_{GE}=\pm 20\text{V}$ , $V_{CE}=0\text{V}$ , $T_j=25^\circ\text{C}$
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	V	-	3.2	-	$I_C=500\text{A}$ , $V_{GE}=15\text{V}$ , $T_j=25^\circ\text{C}$
			3.4	4.3	5.2	$I_C=500\text{A}$ , $V_{GE}=15\text{V}$ , $T_j=125^\circ\text{C}$
Gate Emitter Threshold Voltage	$V_{GE(To)}$	V	5.8	6.3	6.8	$V_{CE}=10\text{V}$ , $I_C=500\text{mA}$ , $T_j=25^\circ\text{C}$
Input Capacitance	$C_{ies}$	nF	-	87	-	$V_{CE}=10\text{V}$ , $V_{GE}=0\text{V}$ , $f=100\text{kHz}$ , $T_j=25^\circ\text{C}$
Internal Gate Resistance	$R_{ge}$	$\Omega$	-	1.1	-	$V_{CE}=10\text{V}$ , $V_{GE}=0\text{V}$ , $f=100\text{kHz}$ , $T_j=25^\circ\text{C}$
Switching Times	Rise Time	$t_r$	2.2	3.2	4.8	$V_{CC}=3,600\text{V}$ , $I_C=500\text{A}$
	Turn On Time	$t_{on}$	2.7	3.9	5.9	$L_s=210\text{nH}$
	Fall Time	$t_f$	2.2	3.1	4.7	$R_G=12\Omega$ (3)
	Turn Off Time	$t_{off}$	4.5	6.4	9.6	$V_{GE}=\pm 15\text{V}$ , $T_j=125^\circ\text{C}$
Peak Forward Voltage Drop	$V_{FM}$	V	-	3.6	-	$I_F=500\text{A}$ , $V_{GE}=0\text{V}$ , $T_j=25^\circ\text{C}$
			3.5	3.9	4.4	$I_F=500\text{A}$ , $V_{GE}=0\text{V}$ , $T_j=125^\circ\text{C}$
Reverse Recovery Time	$t_{rr}$	$\mu\text{s}$	-	0.8	1.6	$V_{CC}=3,600\text{V}$ , $I_F=500\text{A}$ , $L_s=210\text{nH}$ $T_j=125^\circ\text{C}$
Short Circuit Pulse Width	$t_{sc}$	$\mu\text{s}$	10	-	-	$V_{CC}=4500\text{V}$ , $L_s=210\text{nH}$ $R_G(\text{on/off})=12/120\Omega$ , $V_{GE}=\pm 15\text{V}$ , $T_j=25^\circ\text{C}$
Turn On Loss	$E_{on(10\%)}$	J/p	-	3.3	4.3	$V_{CC}=3600\text{V}$ , $I_C=I_F=500\text{A}$ , $L_s=210\text{nH}$ $R_G=12\Omega$ (3) $V_{GE}=\pm 15\text{V}$ , $T_j=125^\circ\text{C}$
	$E_{on(full)}$		-	3.7	-	
Turn Off Loss	$E_{off(10\%)}$	J/p	-	2.6	3.4	
	$E_{off(full)}$		-	2.8	-	
Reverse Recovery Loss	$E_{rr(10\%)}$	J/p	-	1.4	1.8	
	$E_{rr(full)}$		-	1.5	-	

Notes:(3)  $R_G$  value is the test condition's value for evaluation of the switching times, not recommended value.

Please, determine the suitable  $R_G$  value after the measurement of switching waveforms (overshoot voltage, etc.) with appliance mounted.

\* Please contact our representatives at order.

\* For improvement, specifications are subject to change without notice.

\* For actual application, please confirm this spec sheet is the newest revision.

# MBN500H65E2

## THERMAL CHARACTERISTICS

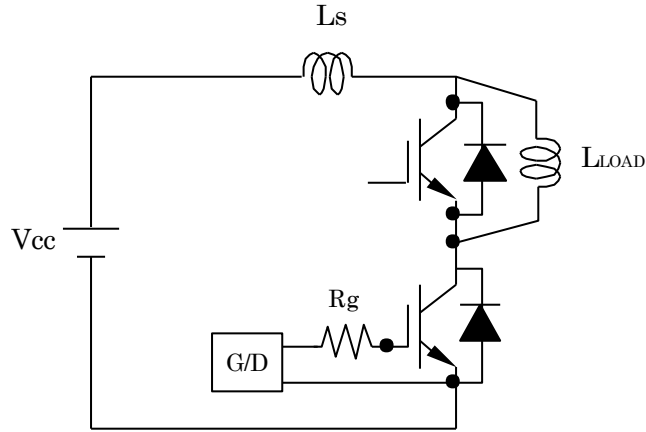
Item		Symbol	Unit	Min.	Typ.	Max.	Conditions
Thermal Impedance	IGBT	Rth(j-c)	K/W	-	-	0.0135	Junction to case
	FWD	Rth(j-c)		-	-	0.027	
Contact Thermal Impedance		Rth(c-f)	K/W	-	0.007	-	Case to fin ( $\lambda_{grease}=1W/(m \cdot K)$ , heat-sink flatness $\leq 50\mu m$ )

## MODULE MECHANICAL CHARACTERISTICS

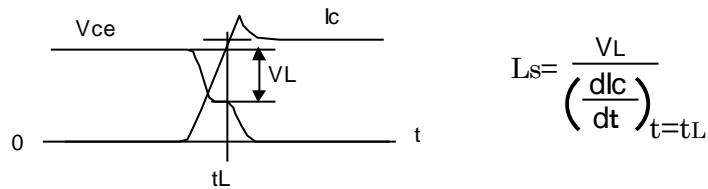
Item		Unit	Characteristics	Conditions
Weight		g	1,050	
Stray inductance in module	LS(CM-EM)	nH	21	Collector-main to Emitter-main
Comparative Tracking Index (CTI)			600	
Module base plate Material			Al-SiC	
Baseplate Thickness		mm	5	
Insulation plate Material			Al N	
Terminal Surface treatment			Ni plating	
Case Material			Poly-Phenilene Sulfide	
Fire and Smoke Category			I2 / F3	NFF 16-102

# MBN500H65E2

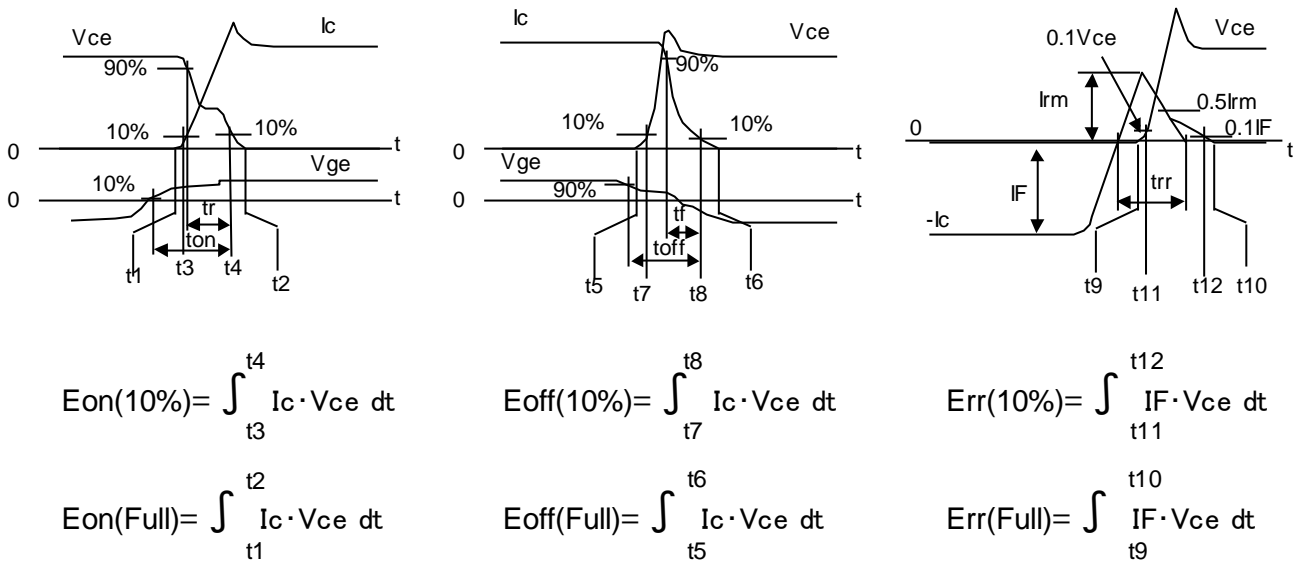
## DEFINITION OF TEST CIRCUIT



**Fig.1 Switching test circuit**



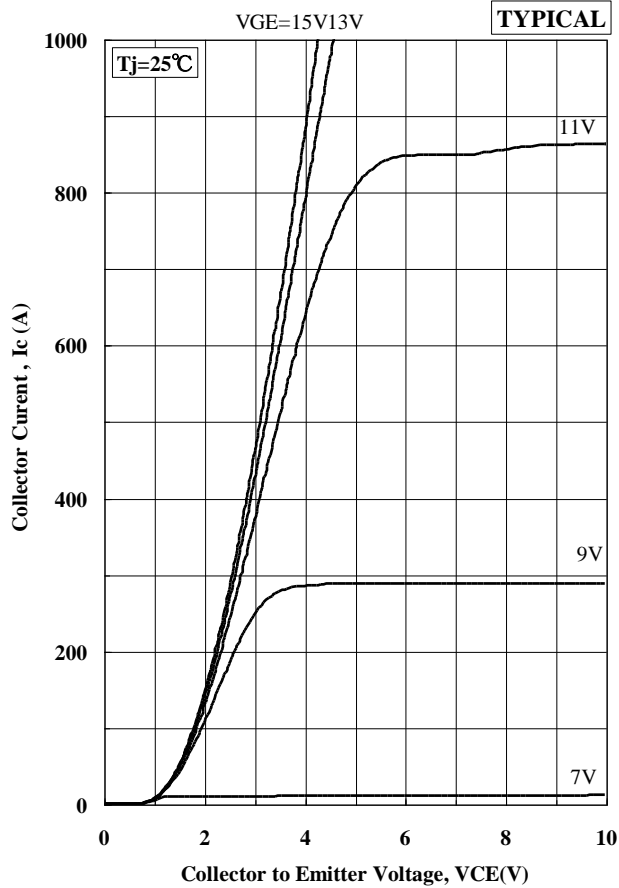
**Fig.2 Definition of Ls**



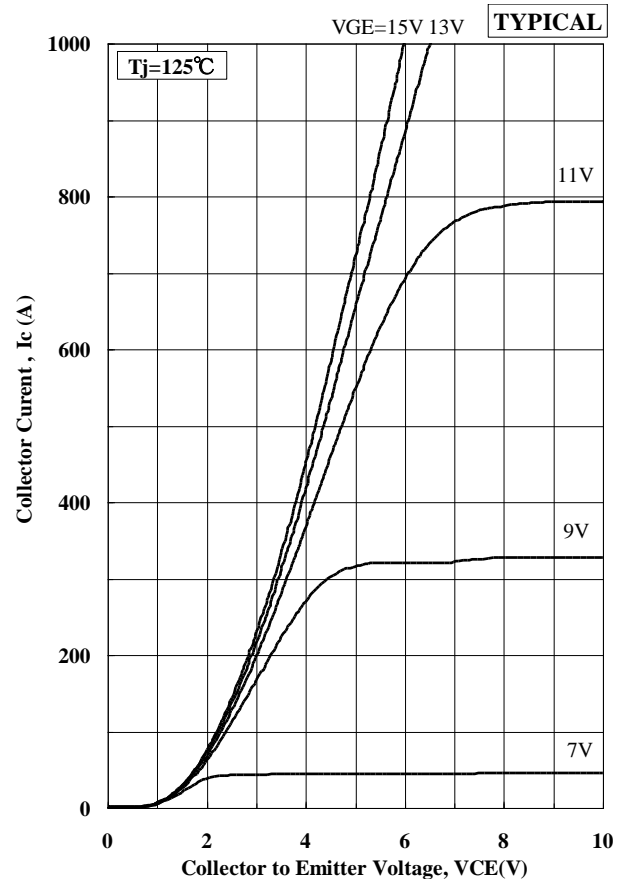
**Fig.3 Definition of switching loss**

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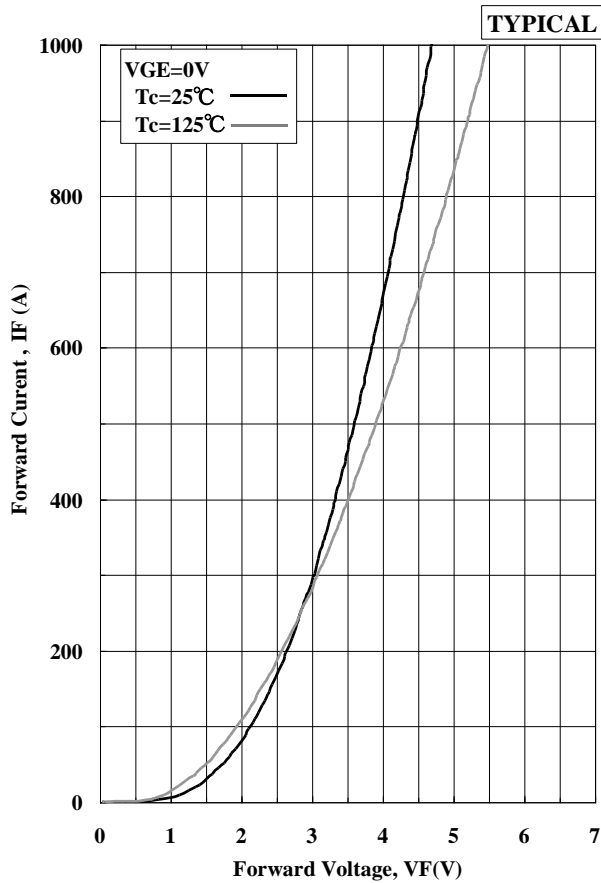
## STATIC CHARACTERISTICS



Collector Current vs. Collector to Emitter Voltage



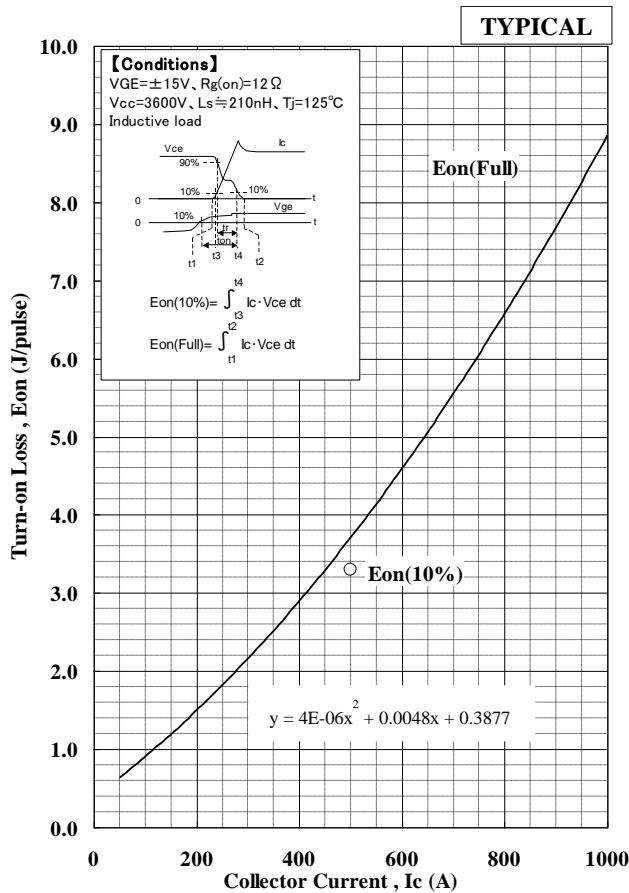
Collector Current vs. Collector to Emitter Voltage



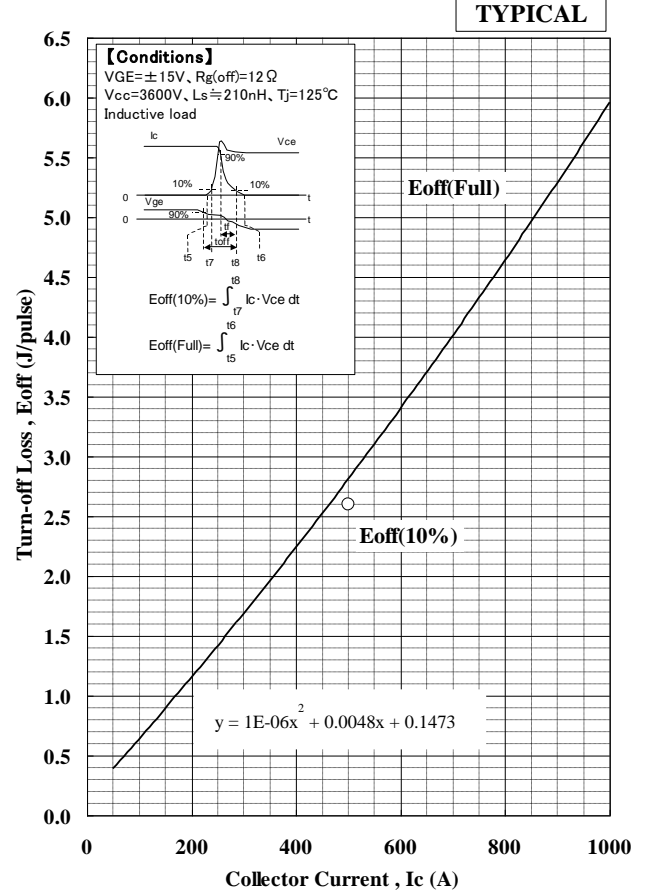
Forward Voltage of free-wheeling diode

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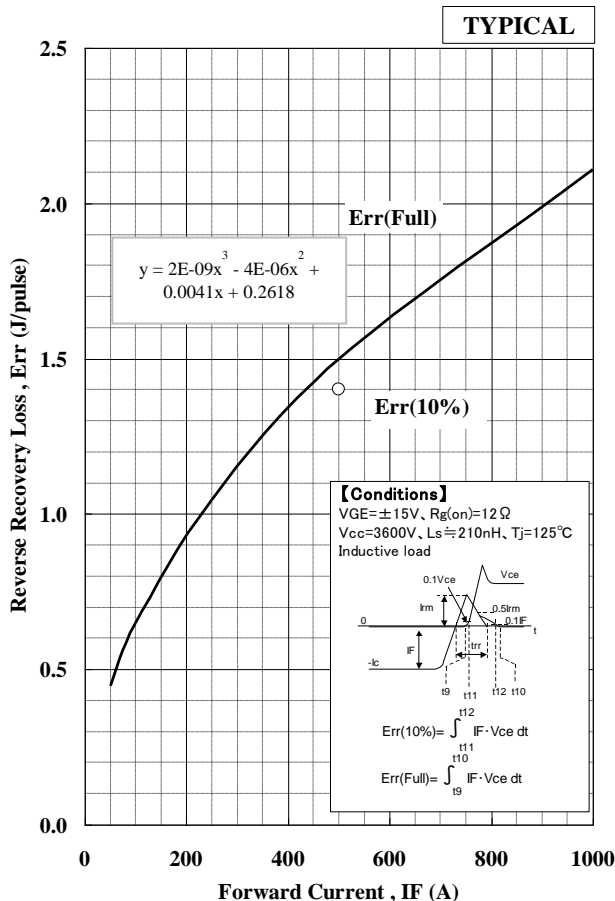
## DYNAMIC CHARACTERISTICS



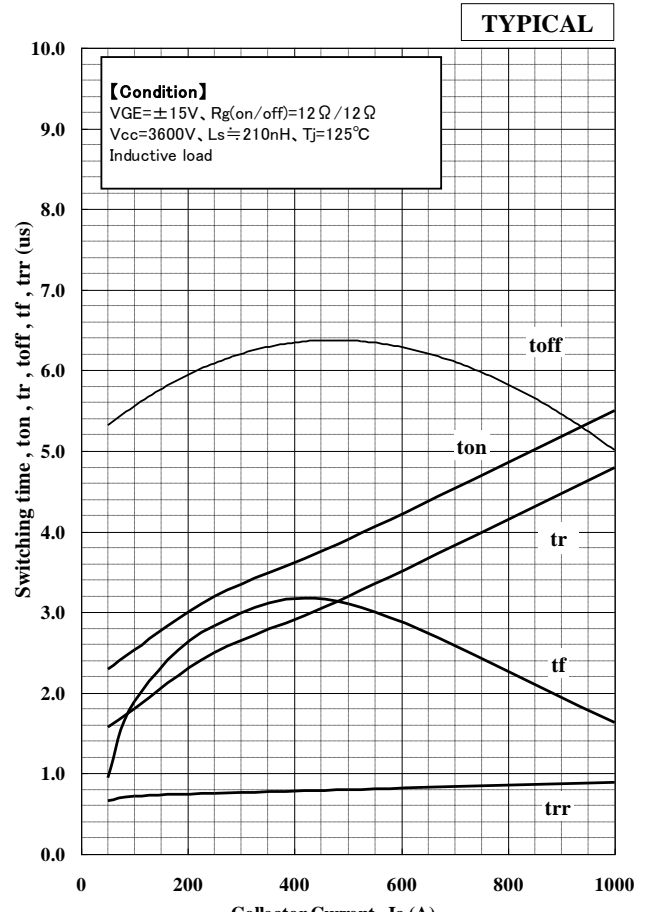
Turn-on Loss vs. Collector Current



Turn-off Loss vs. Collector Current

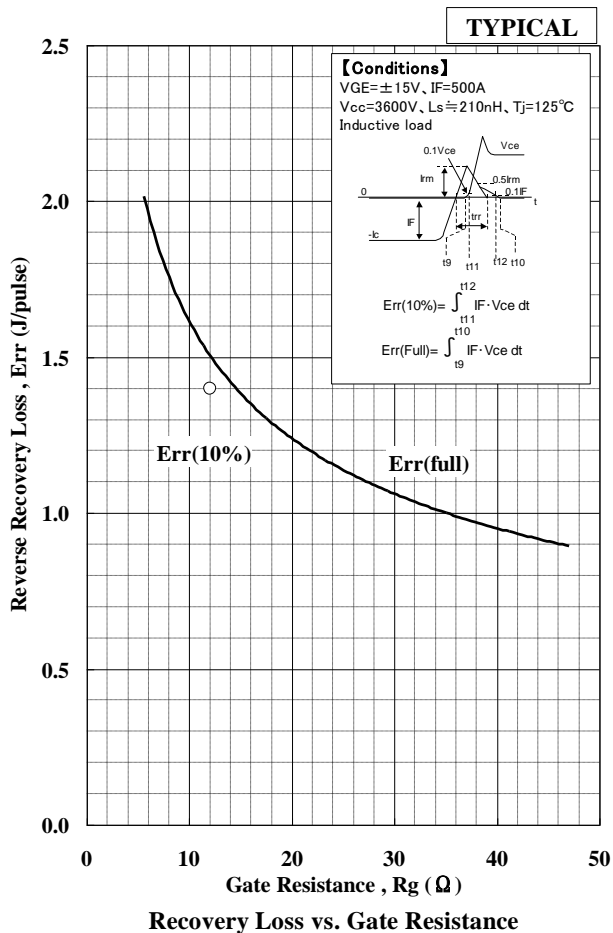
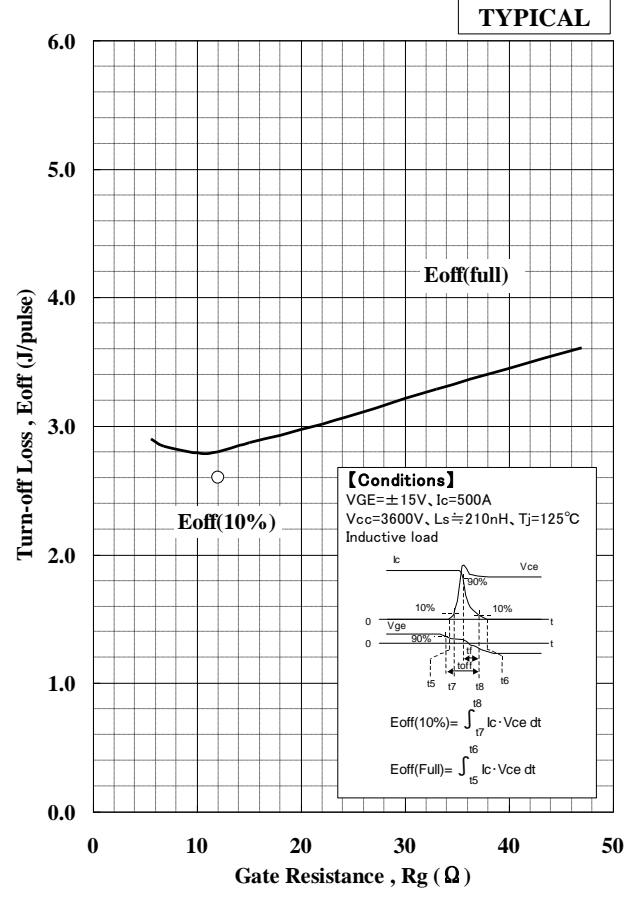
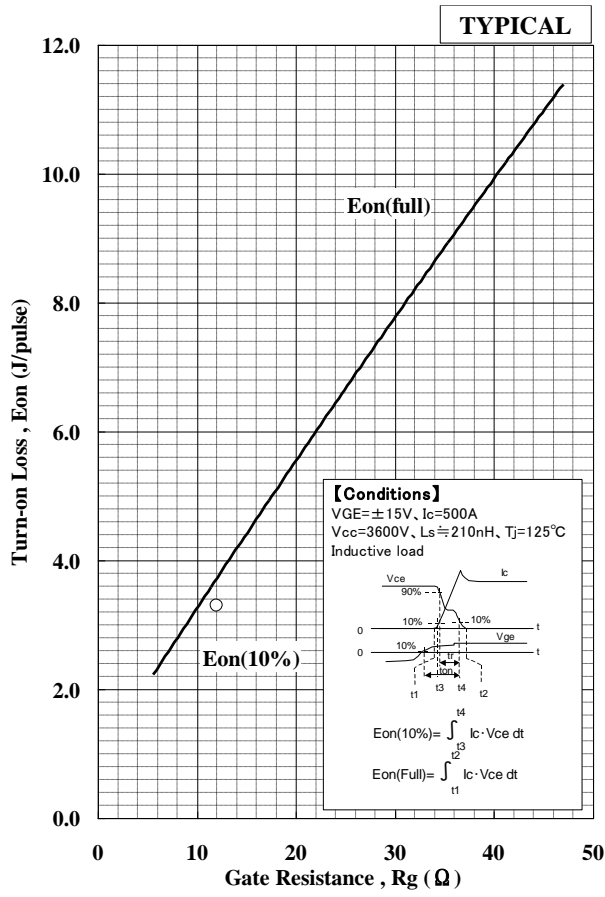


Recovery Loss vs. Forward Current



Switching time vs. Collector current

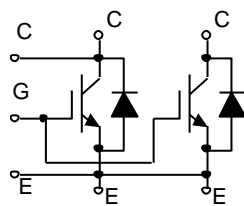
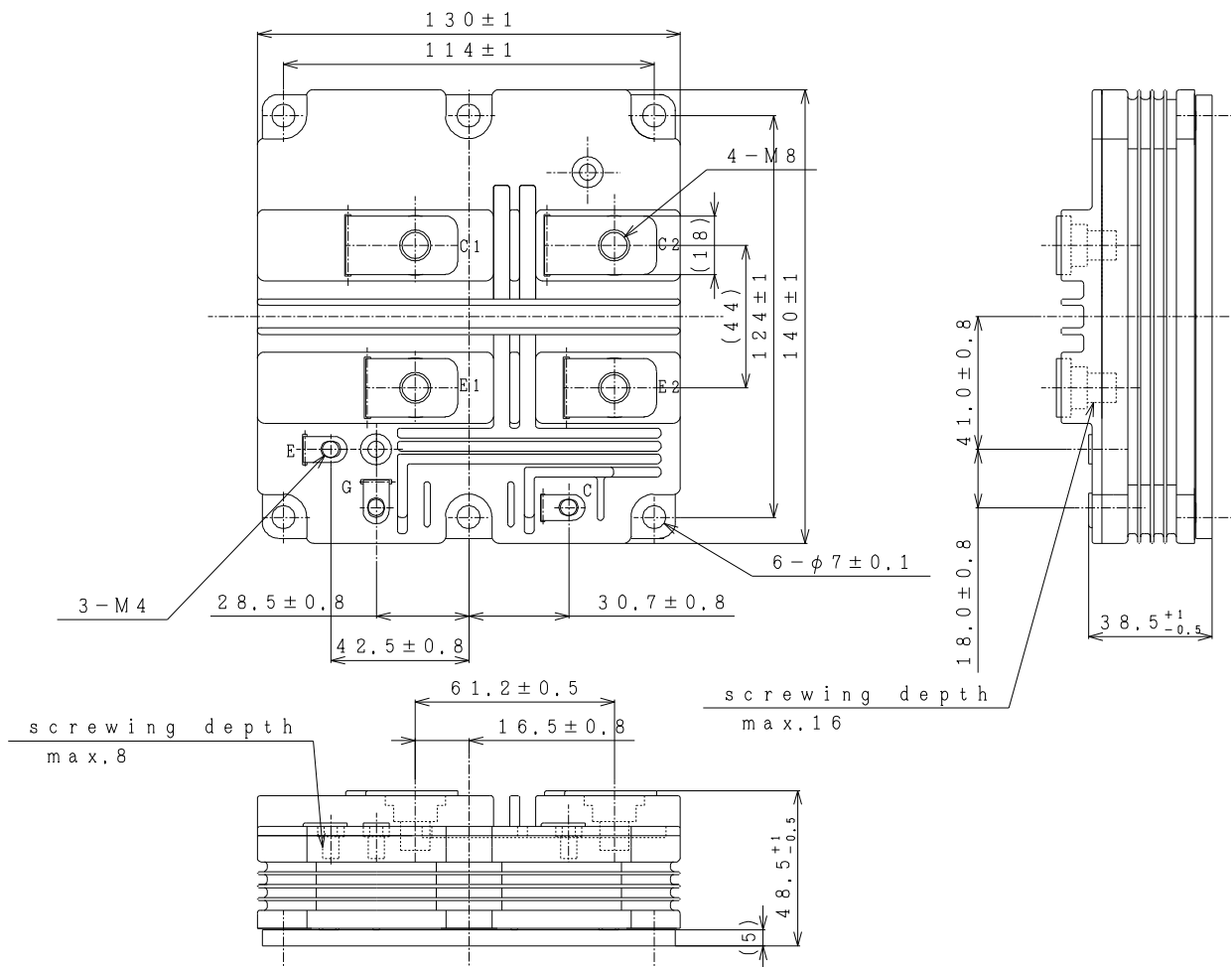
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## PACKAGE OUTLINE DRAWING

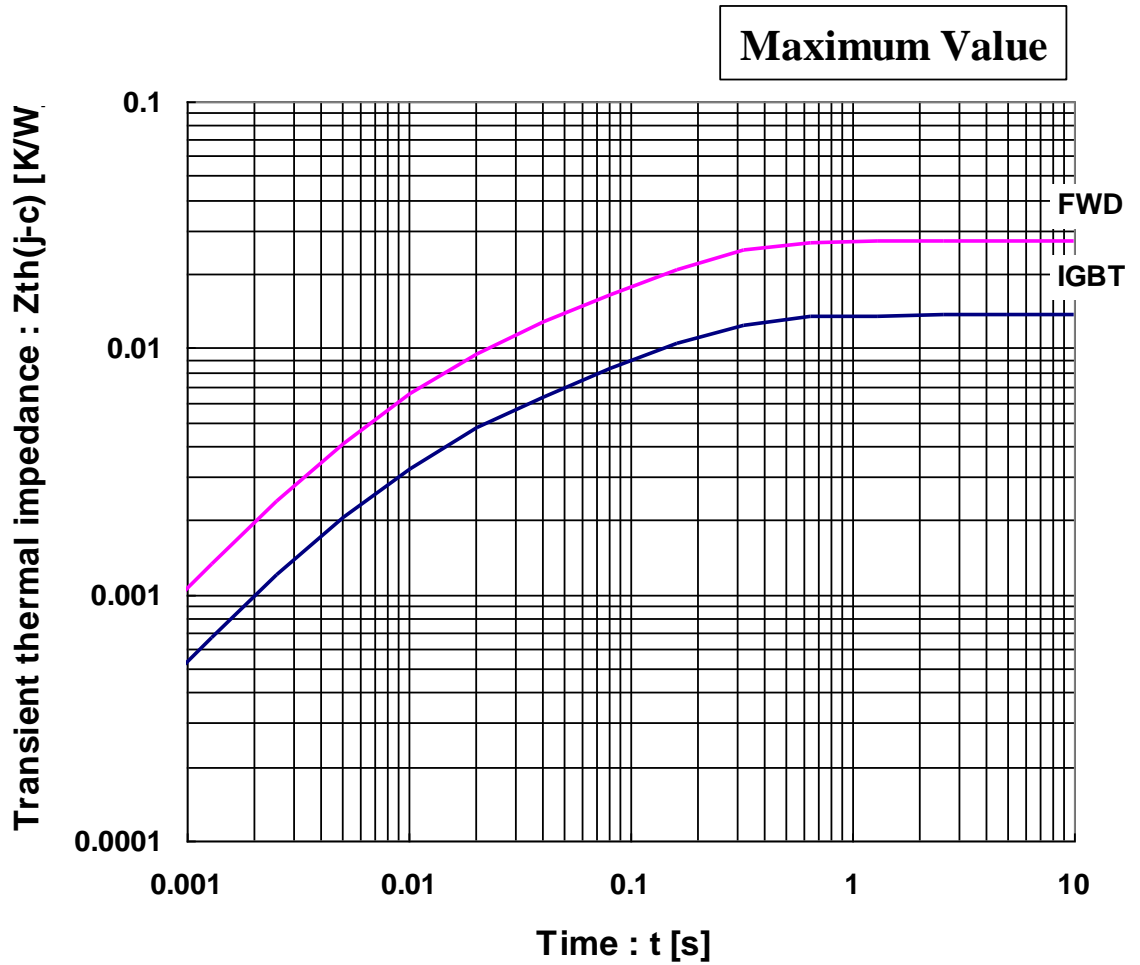
Unit: mm



Circuit diagram

# MBN500H65E2

## TRANSIENT THERMAL IMPEDANCE



Curve approximation model  
 $Z_{th} = \sum r_{th}[n] * (1 - \exp(-t/\tau_{th}[n]))$

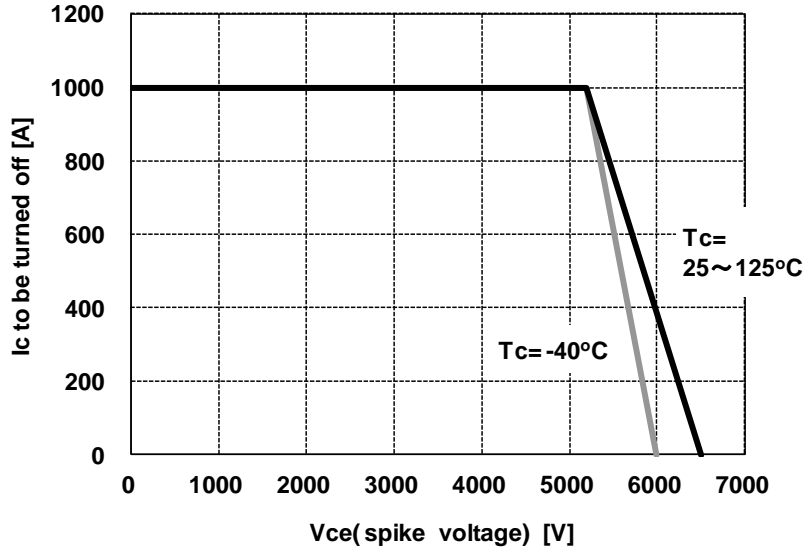
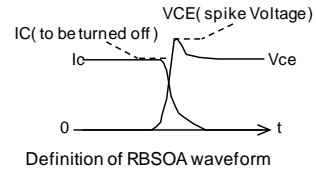
n	1	2	3	4	Unit
$\tau_{th}[n]$	1.64E-01	2.89E-02	7.02E-03	9.42E-04	sec
$r_{th}[n,IGBT]$	8.36E-03	2.59E-03	2.43E-03	1.04E-04	K/W
$r_{th}[n,Diode]$	1.67E-02	5.25E-03	4.81E-03	2.13E-04	K/W



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## RBSOA

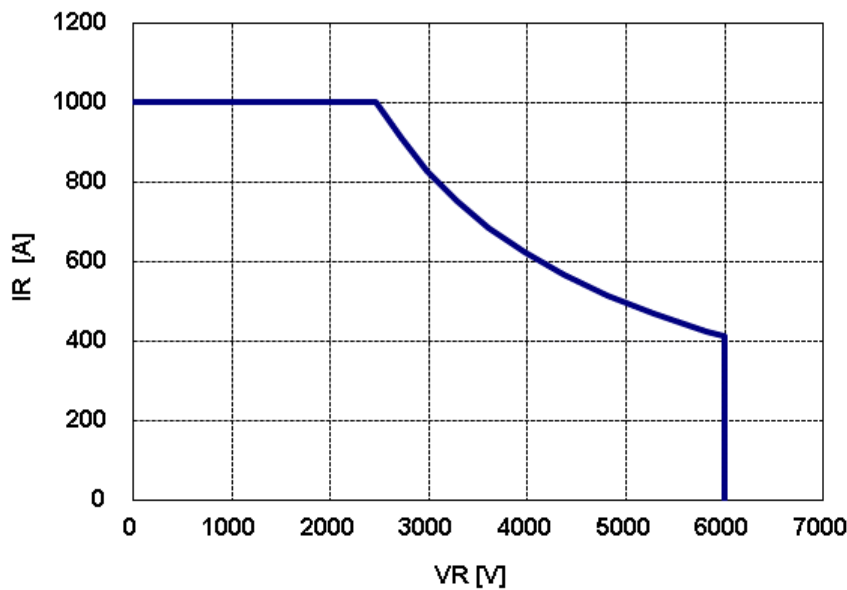
Conditions:  $L_s \leq 210\text{nH}$ ,  $V_{cc} \leq 4400\text{V}$ ,  
 $I_c \leq 1000\text{A}$ ,  $V_{GE} = \pm 15\text{V}$ ,  
 $R_{g(\text{on/off})} \geq 12/12\Omega$ ,  $-40^\circ\text{C} \leq T_c \leq 125^\circ\text{C}$   
 on pulse width  $\geq 20\mu\text{s}$   
 (  $V_{ce}$  spike voltage and  $L_s$  are defined  
 at auxiliary terminal)



## Reverse bias safe operation area ( RBSOA )

## Recovery SOA

Conditions:  
 $L_s \leq 210\text{nH}$ ,  $V_{cc} \leq 4400\text{V}$ ,  $I_R \leq 1000\text{A}$ ,  $V_{GE} = -15\text{V}$ ,  
 $R_{g(\text{on})}$  of across IGBT  $\geq 12\Omega$ ,  $V_{GE}$  of across IGBT  $= \pm 15\text{V}$ ,  
 $-40^\circ\text{C} \leq T_c \leq 125^\circ\text{C}$ ,  $V_R$  defined at auxiliary terminal  
 Conduction pulse width of diode  $\geq 30\mu\text{s}$



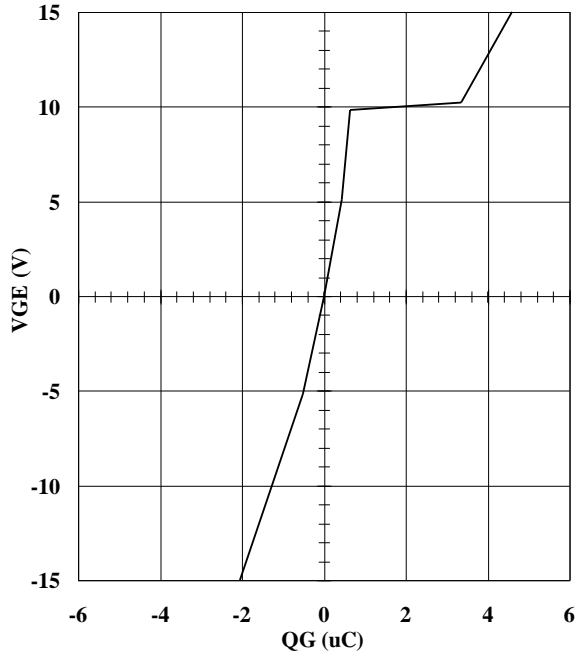
## RecSOA

# MBN500H65E2

**QG-VGE Curve**

**TYPICAL**

Conditions:  $L_s=300\text{nH}$ ,  $V_{CC}=3600\text{V}$ ,  $V_{GE}=\pm 15\text{V}$ ,  
 $R_{G(\text{on/off})}=68\Omega/12\Omega$ ,  $T_j=25^\circ\text{C}$ ,



**QG-VGE curve**

**Material declaration**

Please note the following materials are contained in the product, in order to keep characteristic and reliability level.

Material	Contained part
Lead (Pb) and its compounds	Solder

# MBN500H65E2

## HITACHI POWER SEMICONDUCTORS

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